



Selective Passivation of Nitrogen Defects in GaInNAs Solar Cells

N. J. Estes¹, M. Fukuda¹, V. R. Whiteside¹,
J. C. Keay¹, M. Al Khalfioui², M. Leroux², K Hossain³, T. D.
Golding³, B. Wang⁴, C. T. Ellis⁵, J. Tischler⁵ and I. R. Sellers¹

¹ Department of Physics & Astronomy, University of Oklahoma, Norman, OK 73019, USA

² CRHEA-CNRS, Rue Bernard Gregory, Valbonne 06560, France

³ Amethyst Research Inc., 123 Case Circle, Ardmore, OK 73401, USA

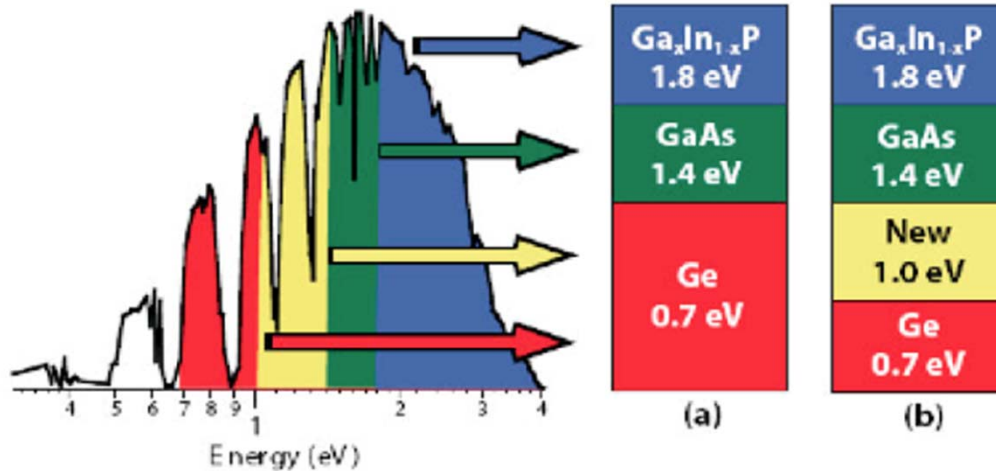
⁴School of Biological, Chemical, and Materials Engineering, University of Oklahoma, OK 73019, USA

⁵US Naval Research Laboratory, 4555 Overlook Ave SW, Washington, DC 20375, USA

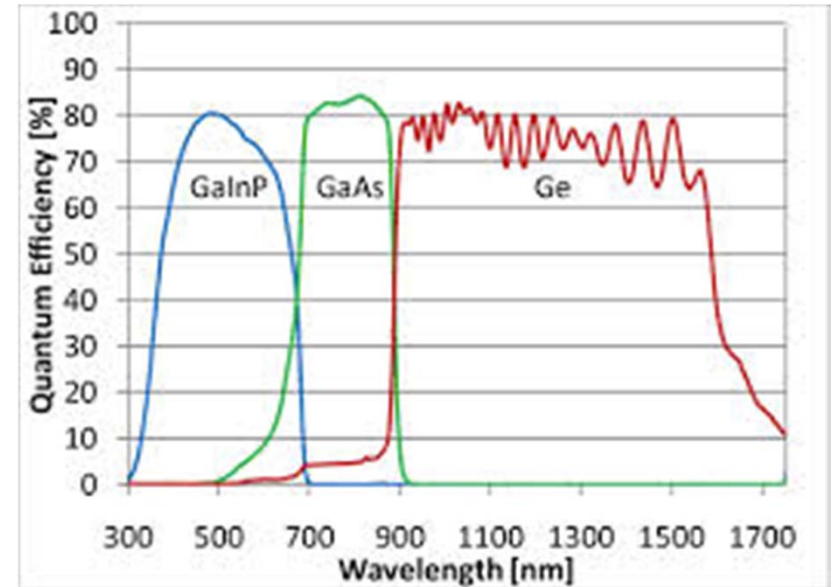




Multijunction Solar Cells: Divide and Conquer



J.F. Geisz and D.J.Freidman, *Semiconductor Science and Technology* 17, 769 (2002)



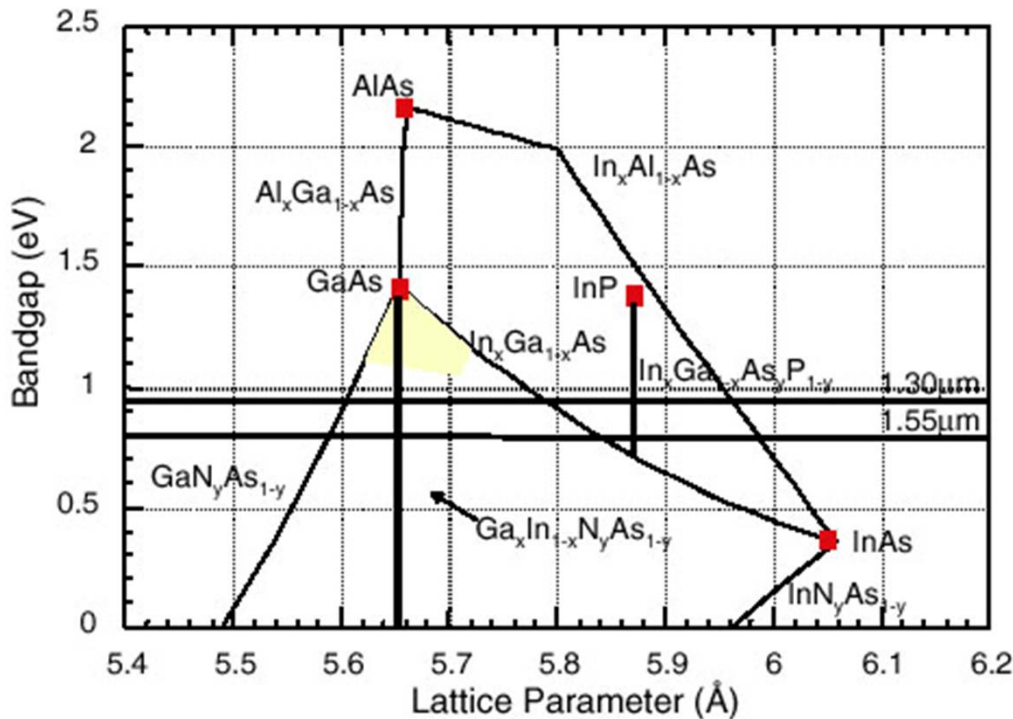
<http://www.pvmeasurements.com/>

- Three junctions: 44% efficient
- Four junctions: Up to 52% efficient
- Power wasted by Ge due to poor current matching

We need a material with 1eV bandgap,
correct lattice spacing



GaInNAs is a Promising but Problematic Candidate for the Fourth Junction



J. S. Harris, *Semicond. Sci. Technol.* 17, 880 (2002)

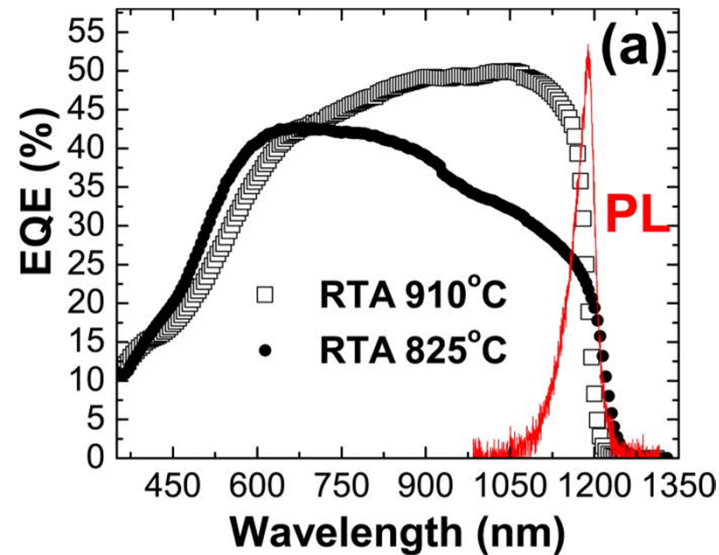
Growth Problems:

- High temperature-- phase separation, clustering
- Low temperature-- defect formation, low nitrogen inclusion

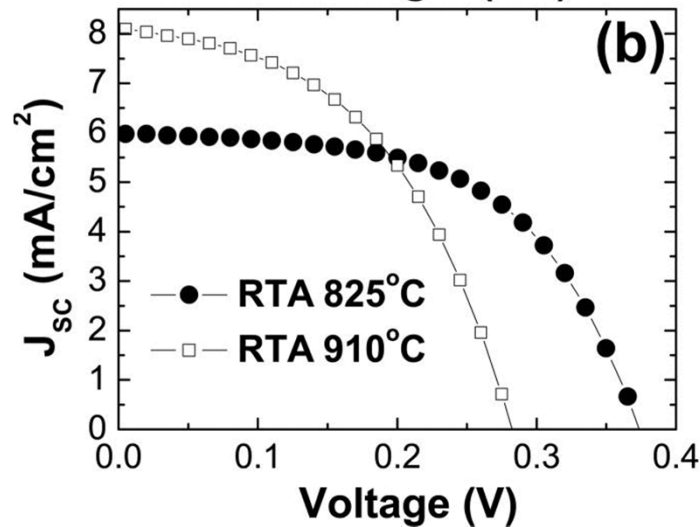
Regardless of sample quality, substitutional N is locally different electrically than As, causing low diffusion lengths.



Annealing (RTA) Reduces Problems Associated with Growth Temperature



- More ideal quantum efficiency in solar cell structures
- Reduced recombination losses
- Breaking up of N-N clusters



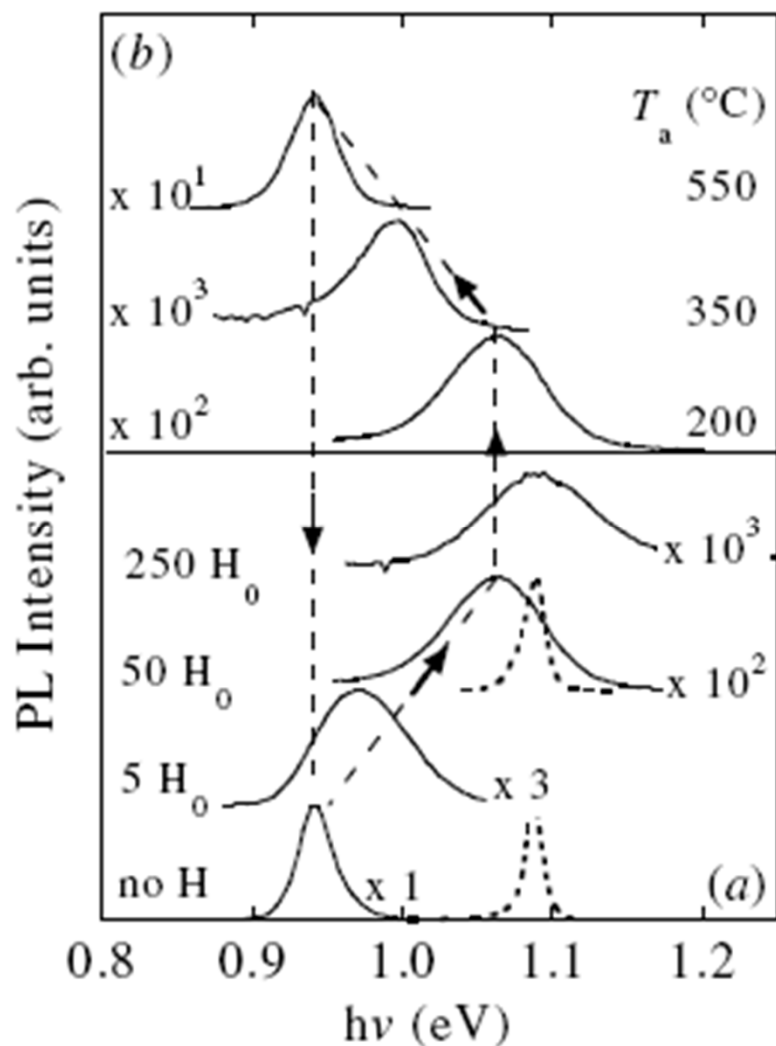
Dilute nitride MJSCs have seen efficiencies in excess of 43%

M. Wiemer, V. Sabnis, H. Yuen, *Proc. SPIE*, 2011, **8108**, 810804.

Sellers et al. *Appl. Phys. Lett.* 99, 151111 (2011)

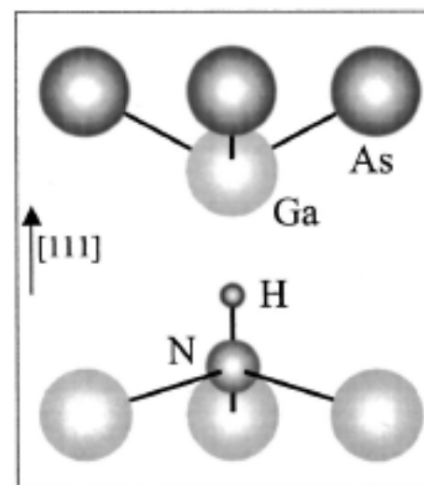
Photovoltaics Materials & Device Group, University of Oklahoma: <http://www.nhn.ou.edu/~sellers/group/index.html>

Hydrogenation Has Shown Passivation of Substitutional Nitrogen



Polimeni *et al.* *Semi. Sci Tech.* **797**, (2002)

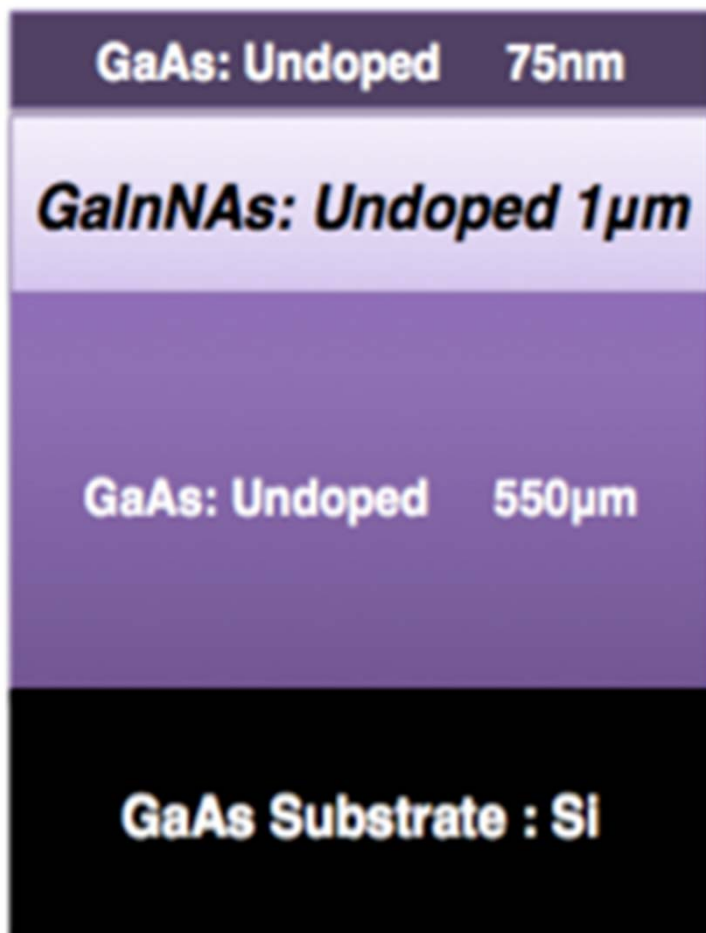
- Restoration of original band gap
- Process reversible through RTA
- Favorable due to small, electronegative nitrogen



Bissiri *et al.* *Phys. Rev. B.* **65**, 235210 (2002)



Samples Used



Bulk $\text{Ga}_{0.91}\text{In}_{0.09}\text{N}_{0.028}\text{As}_{0.972}$
annealed at 800°C

CRHEA

UV-Activated
hydrogenation,
 $2\ \mu\text{m}$ penetration



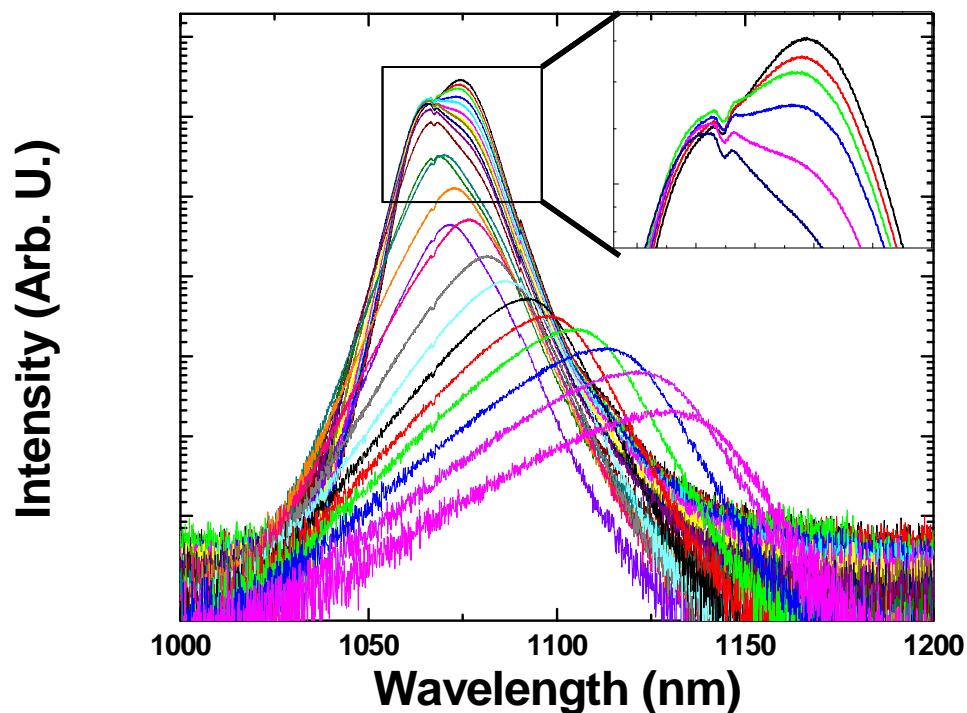
Three samples:

- Reference – Unhydrogenated
- #9 – Intermediate hydrogenation
- #8 – High hydrogenation

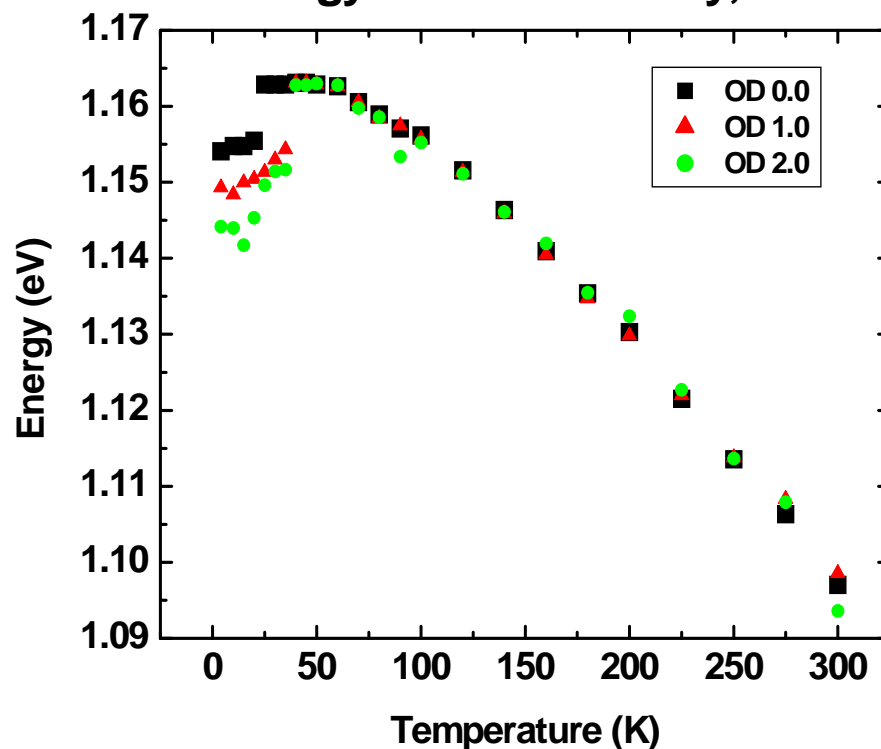


Isoelectronic Effects Remain After Annealing in Reference

Reference PL by T



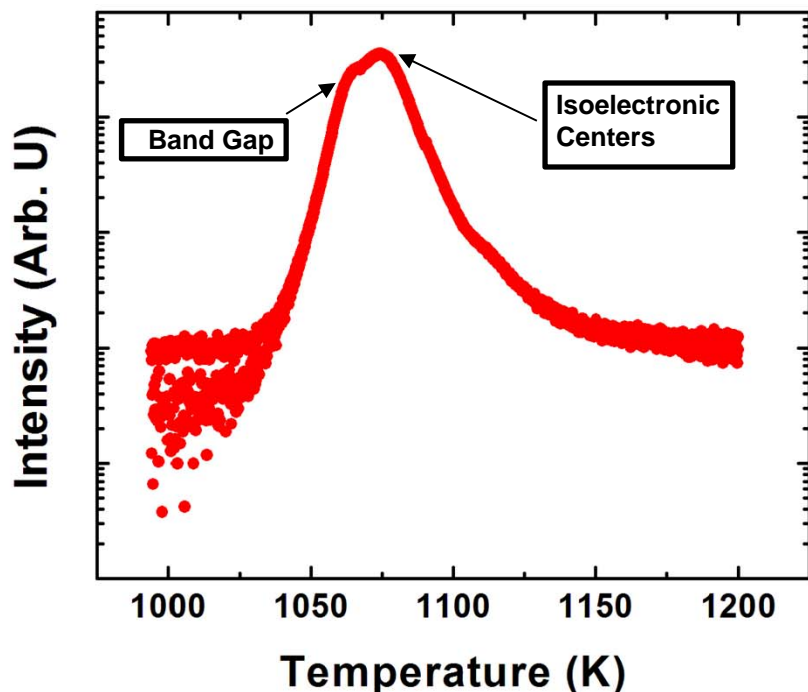
Energy at Peak Intensity, Ref



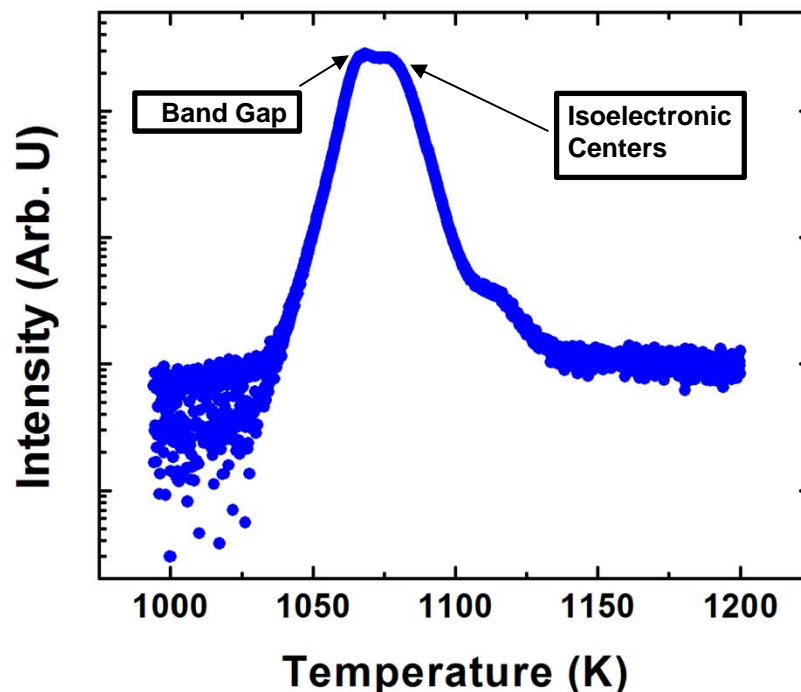


Hydrogenation of GaInNAs Mitigates Isoelectronic Effects, Retains Band Gap

Reference PL, 4K



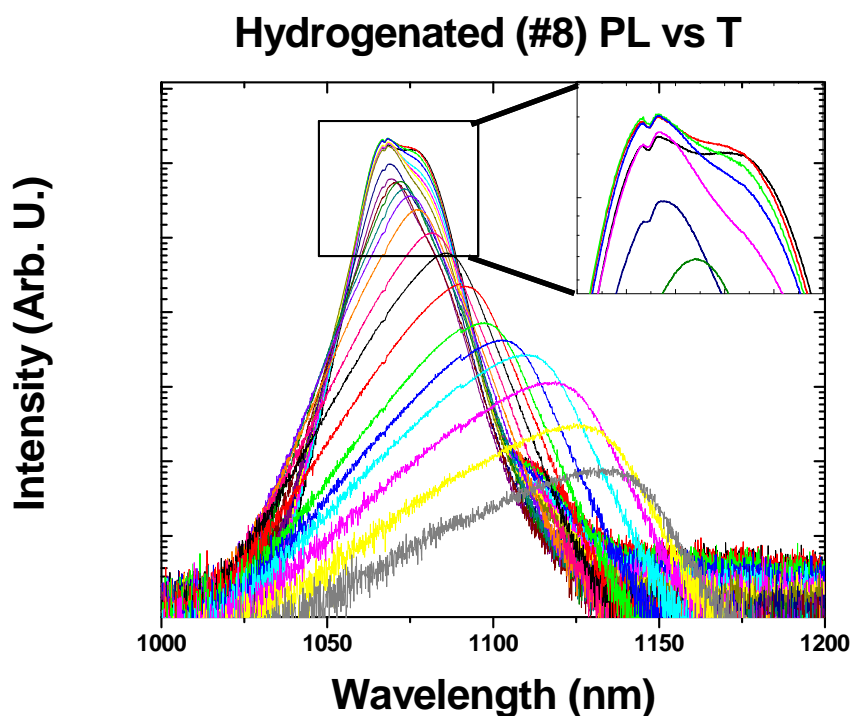
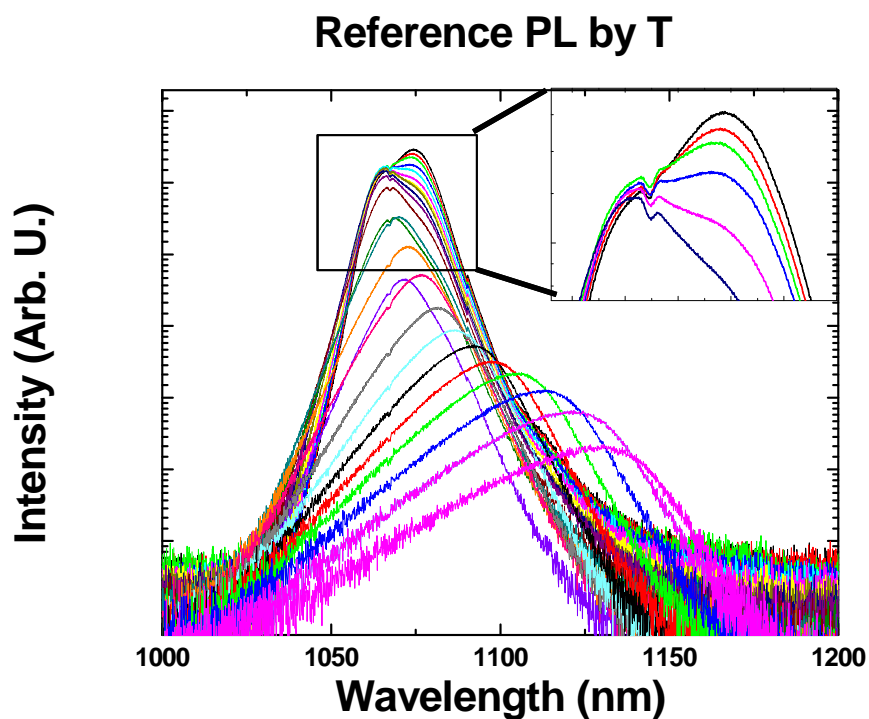
Hydrogenated Sample (#8), 4K



Reduction in intensity of low-energy “shoulder”



Hydrogenation of GaInNAs Mitigates Isoelectronic Effects, Retains Band Gap

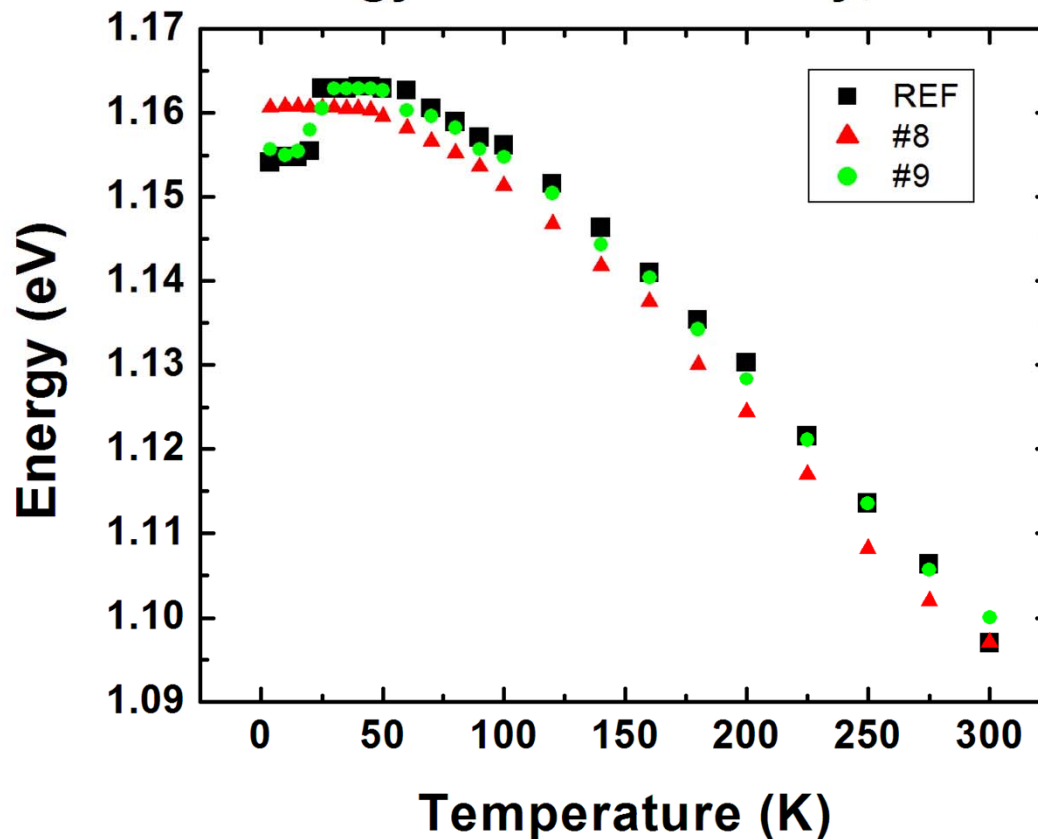


Peak now has reduced 's-shape' with temperature



Hydrogenation of GaInNAs Mitigates Isoelectronic Effects, Retains Band Gap

Energy at Peak Intensity, ND0



- Samples correlate well at high temp
- Isoelectronic states quenched under high light intensity



Summary



- The hydrogenated samples exhibit lessened effects of isoelectronic centers while retaining substitutional nitrogen
- Further studies will be conducted to verify which N-H complexes are forming and to analyze their effect on the band structure and carriers.

Acknowledgements

OCAST»

Oklahoma Center for the Advancement of Science and Technology

CRHEA



CRHEA

Photovoltaics Materials & Device Group, University of Oklahoma: <http://www.nhn.ou.edu/~sellers/group/index.html>

